













ESD

103

TSS

MOV

GDT

PLED

SI2302CDS-T1-GE3-MS Product specification





Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
20V	40mΩ	3A

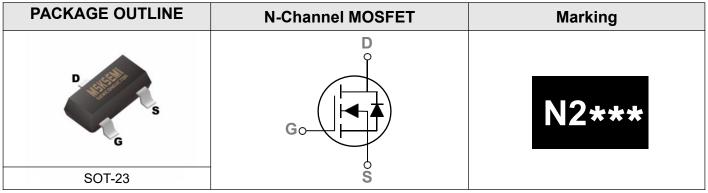
Features

- 20V, 3A, RDS(ON) =40mΩ@VGS = 4.5V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

Reference News



Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	20	V
Vgs	Gate-Source Voltage	±12	V
	Drain Current – Continuous (Tc=25°C)	3	A
D	Drain Current – Continuous (T _C =100°C)	2	А
Ідм	Drain Current – Pulsed ¹	16	A
Dr	Power Dissipation (T _C =25°C)	1.56	W
Po	Power Dissipation – Derate above 25°C	0.012	W/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W



Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	rain-Source Breakdown Voltage V _{GS} =0V,I _D =250uA				V
∆BV _{DSS} /∆T _J	BV _{DSS} Temperature Coefficient	Reference to 25° C , I _D =1mA		0.02		V/°C
IDSS	Drain-Source Leakage Current	V _{DS} =20V , V _{GS} =0V , T _J =25°C			1	uA
	g	V _{DS} =16V , V _{GS} =0V , T _J =125°C			10	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 12V$, $V_{DS}=0V$			±100	nA

On Characteristics

B	RDS(ON) Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =2A		40	55	mΩ	
R _{DS(ON)}		V _{GS} =2.5V , I _D =1A		55	75	11152	
VGS(th)	Gate Threshold Voltage			0.5	1	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			2		mV/℃	
gfs	Forward Transconductance	V _{DS} =10V , I _S =2A		4.4		S	

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			3.6	
Qgs	Gate-Source Charge ² , ³	$V_{\text{DS}}\text{=}10V$, $V_{\text{GS}}\text{=}4.5V$, $I_{\text{D}}\text{=}1A$		0.38	 nC
Q _{gd}	Gate-Drain Charge ^{2 , 3}			0.6	
T _{d(on)}	Turn-On Delay Time ^{2, 3}			1.8	
Tr	Rise Time ^{2, 3}	V _{DD} = 10V,V _{GS} =4.5V,		5.6	 -0
T _{d(off)}	Turn-Off Delay Time ^{2 , 3}	R _G =25Ω I _D =1A		11.3	 nS
T _f	Fall Time ^{2, 3}			3.2	
Ciss	Input Capacitance			180	
Coss	Output Capacitance	V_{DS} = 15V , V_{GS} =0V , F=1MHz		32	 pF
Crss	Reverse Transfer Capacitance			26	

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	$V_G = V_D = 0V$, Force Current			3	А
lsм	Pulsed Source Current				6	А
V _{SD}	Diode Forward Voltage	V _{GS} =0V,I _S =1A,T _J =25°C			1.2	V

Note :

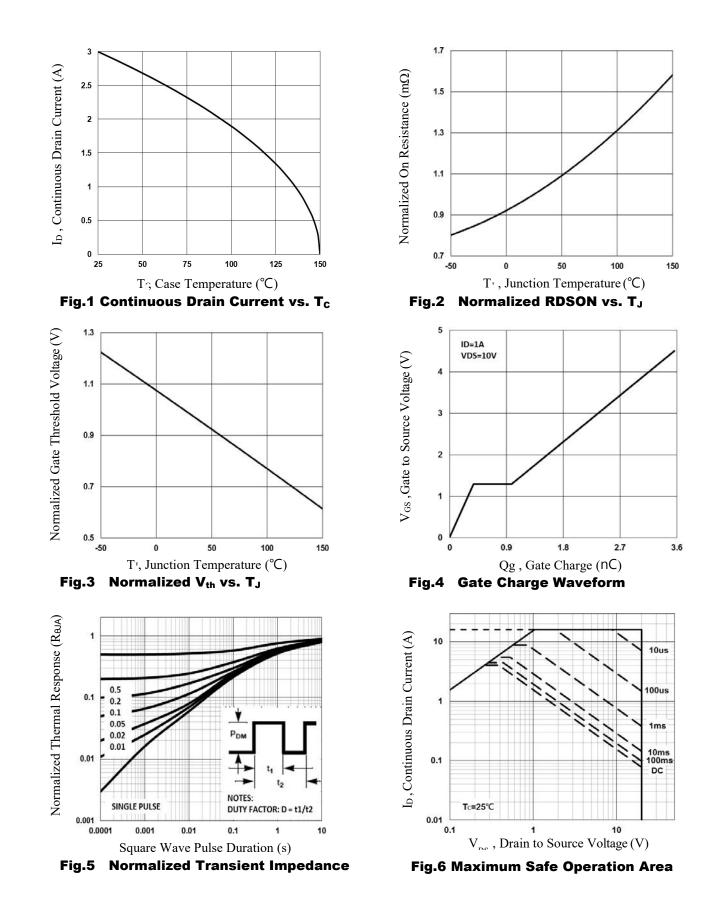
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

2. The data tested by pulsed , pulse width \leq 300us , duty cycle $\,\leq\,$ 2%.

3. Essentially independent of operating temperature.

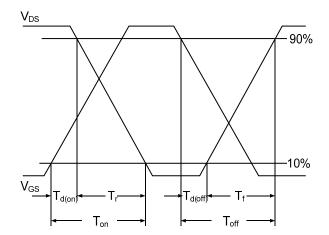


SI2302CDS-T1-GE3-MS





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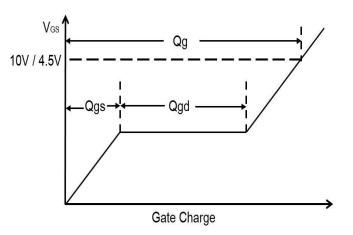
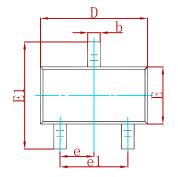
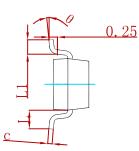


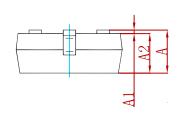


Fig.8 Gate Charge Waveform

PACKAGE MECHANICAL DATA

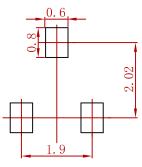






Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
А	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

1.Controlling dimension: in millimeters.

- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.

REELSPECIFICATION

P/N	PKG	QTY
SI2302CDS-T1-GE3-MS	SOT-23	3000



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